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Measurement uncertainty for metrological applications — Repeated measurements and nested experiments

*Incertitude de mesure pour les applications en métrologie — Mesures
répétées et expériences emboîtées*



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Contents

Page

Foreword	iv
Introduction	v
1 Scope	1
2 Normative references	1
3 Terms and definitions	2
4 Statistical methods of uncertainty evaluation	3
4.1 Approach of the <i>Guide to the expression of uncertainty of measurement</i>	3
4.2 Check standards	4
4.3 Steps in uncertainty evaluation	5
4.4 Examples in this Technical Specification	6
5 Type A evaluation of uncertainty	6
5.1 General	6
5.2 Role of time in Type A evaluation of uncertainty	7
5.3 Measurement configuration	14
5.4 Material inhomogeneity	16
5.5 Bias due to measurement configurations	17
6 Type B evaluation of uncertainty	26
7 Propagation of uncertainty	27
7.1 General	27
7.2 Formulae for functions of a single variable	28
7.3 Formulae for functions of two variables	28
8 Example — Type A evaluation of uncertainty from a gauge study	30
8.1 Purpose and background	30
8.2 Data collection and check standards	30
8.3 Analysis of repeatability, day-to-day and long-term effects	31
8.4 Probe bias	31
8.5 Wiring bias	33
8.6 Uncertainty calculation	35
Annex A (normative) Symbols	37
Bibliography	38

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

In other circumstances, particularly when there is an urgent market requirement for such documents, a technical committee may decide to publish other types of normative document:

- an ISO Publicly Available Specification (ISO/PAS) represents an agreement between technical experts in an ISO working group and is accepted for publication if it is approved by more than 50 % of the members of the parent committee casting a vote.
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An ISO/PAS or ISO/TS is reviewed after three years in order to decide whether it will be confirmed for a further three years, revised to become an International Standard, or withdrawn. If the ISO/PAS or ISO/TS is confirmed, it is reviewed again after a further three years, at which time it must either be transformed into an International Standard or be withdrawn.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO/TS 21749 was prepared by Technical Committee ISO/TC 69, *Applications of statistical methods*, Subcommittee SC 6, *Measurement methods and results*.

This corrected version of ISO/TS 21749:2005 incorporates the correction of the title.

Introduction

Test, calibration and other laboratories are frequently required to report the results of measurements and the associated uncertainties. Evaluation of uncertainty is an on-going process that can consume time and resources. In particular, there are many tests and other operations carried out by laboratories where two or three sources of uncertainty are involved. Following the approach in the *Guide to the expression of uncertainty of measurement (GUM)* to combining components of uncertainty, this document focuses on using the analysis of variance (ANOVA) for estimating individual components, particularly those based on Type A (statistical) evaluations.

An experiment is designed by the laboratory to enable an adequate number of measurements to be made, the analysis of which will permit the separation of the uncertainty components. The experiment, in terms of design and execution, and the subsequent analysis and uncertainty evaluation, require familiarity with data analysis techniques, particularly statistical analysis. Therefore, it is important for laboratory personnel to be aware of the resources required and to plan the necessary data collection and analysis.

In this Technical Specification, the uncertainty components based on Type A evaluations can be estimated from statistical analysis of repeated measurements, from instruments, test items or check standards.

A purpose of this Technical Specification is to provide guidance on the evaluation of the uncertainties associated with the measurement of test items, for instance as part of ongoing manufacturing inspection. Such uncertainties contain contributions from the measurement process itself and from the variability of the manufacturing process. Both types of contribution include those from operators, environmental conditions and other effects. In order to assist in separating the effects of the measurement process and manufacturing variability, measurements of check standards are used to provide data on the measurement process itself. Such measurements are nominally identical to those made on the test items. In particular, measurements on check standards are used to help identify time-dependent effects, so that such effects can be evaluated and contrasted with a database of check standard measurements. These standards are also useful in helping to control the bias and long-term drift of the process once a baseline for these quantities has been established from historical data.

Clause 4 briefly describes the statistical methods of uncertainty evaluation including the approach recommended in the *GUM*, the use of check standards, the steps in uncertainty evaluation and the examples in this Technical Specification. Clause 5, the main part of this Technical Specification, discusses the Type A evaluations. Nested designs in ANOVA are used in dealing with time-dependent sources of uncertainty. Other sources such as those from the measurement configuration, material inhomogeneity, and the bias due to measurement configurations and related uncertainty analyses are discussed. Type B (non-statistical) evaluations of uncertainty are discussed for completeness in Clause 6. The law of propagation of uncertainty described in the *GUM* has been widely used. Clause 7 provides formulae obtained by applying this law to certain functions of one and two variables. In Clause 8, as an example, a Type A evaluation of uncertainty for a gauge study is discussed, where uncertainty components from various sources are obtained. Annex A lists the statistical symbols used in this Technical Specification.

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Measurement uncertainty for metrological applications — Repeated measurements and nested experiments

1 Scope

This Technical Specification follows the approach taken in the *Guide to the expression of the uncertainty of measurement (GUM)* and establishes the basic structure for stating and combining components of uncertainty. To this basic structure, it adds a statistical framework using the analysis of variance (ANOVA) for estimating individual components, particularly those classified as Type A evaluations of uncertainty, i.e. based on the use of statistical methods. A short description of Type B evaluations of uncertainty (non-statistical) is included for completeness.

This Technical Specification covers experimental situations where the components of uncertainty can be estimated from statistical analysis of repeated measurements, instruments, test items or check standards.

It provides methods for obtaining uncertainties from single-, two- and three-level nested designs only. More complicated experimental situations where, for example, there is interaction between operator effects and instrument effects or a cross effect, are not covered.

This Technical Specification is not applicable to measurements that cannot be replicated, such as destructive measurements or measurements on dynamically varying systems (such as fluid flow, electronic currents or telecommunications systems). It is not particularly directed to the certification of reference materials (particularly chemical substances) and to calibrations where artefacts are compared using a scheme known as a “weighing design”. For certification of reference materials, see ISO Guide 35^[14].

When results from interlaboratory studies can be used, techniques are presented in the companion guide ISO/TS 21748^[15]. The main difference between ISO/TS 21748 and this Technical Specification is that the ISO/TS 21748 is concerned with reproducibility data (with the inevitable repeatability effects), whereas this Technical Specification concentrates on repeatability data and the use of the analysis of variance for its treatment.

This Technical Specification is applicable to a wide variety of measurements, for example, lengths, angles, voltages, resistances, masses and densities.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 3534-1:1993, *Statistics — Vocabulary and symbols — Part 1: Probability and general statistical terms*

ISO 3534-3:1999, *Statistics — Vocabulary and symbols — Part 3: Design of experiments*

ISO 5725-1, *Accuracy (trueness and precision) of measurement methods and results — Part 1: General principles and definitions*

ISO 5725-2, *Accuracy (trueness and precision) of measurement methods and results — Part 2: Basic method for the determination of repeatability and reproducibility of a standard measurement method*

ISO 5725-3, *Accuracy (trueness and precision) of measurement methods and results — Part 3: Intermediate measures of the precision of a standard measurement method*

ISO 5725-4, *Accuracy (trueness and precision) of measurement methods and results — Part 4: Basic methods for the determination of the trueness of a standard measurement method*

ISO 5725-5, *Accuracy (trueness and precision) of measurement methods and results — Part 5: Alternative methods for the determination of the precision of a standard measurement method*

ISO 5725-6, *Accuracy (trueness and precision) of measurement methods and results — Part 6: Use in practice of accuracy values*

Guide to the expression of uncertainty in measurement (GUM), BIPM, IEC, IFCC, ISO, IUPAC, IUPAP, OIML, 1993, corrected and reprinted in 1995

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 3534-1, ISO 3534-3, ISO 5725 (all parts) and the following apply.

3.1

measurand

well-defined physical quantity that is to be measured and can be characterized by an essentially unique value

3.2

uncertainty of measurement

parameter or an estimate of the parameter, associated with the result of a measurement, that characterizes the dispersion of the values that could reasonably be attributed to the quantity being measured

3.3

Type A evaluation

method of evaluation of uncertainty by using statistical methods

3.4

Type B evaluation

method of evaluation of uncertainty by means other than statistical methods

3.5

standard uncertainty

uncertainty expressed as a standard deviation associated with a single component of uncertainty

3.6

combined standard uncertainty

standard deviation associated with the result of a particular measurement or series of measurements that takes into account one or more components of uncertainty

3.7

expanded uncertainty

combined standard uncertainty multiplied by a coverage factor which usually is an appropriate critical value from the t -distribution which depends upon the degrees of freedom in the combined standard uncertainty and the desired level of coverage

3.8

effective degrees of freedom

degrees of freedom associated with a standard deviation composed of two or more components of variance

NOTE The effective degrees of freedom can be computed using the Welch-Satterthwaite approximation (see *GUM*, G.4).